

Notice of References Cited

Application/Control No.

10/542,169

Applicant(s)/Patent Under
Reexamination
BOYD ET AL.

Examiner

Golam M. M. Shameem, Ph.D.

Art Unit

1626

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,545,036	04-2003	Garcia et al.	514/415
*	B	US-6,914,070	07-2005	Garcia et al.	514/415
*	C	US-7,037,929	05-2006	Pevarello et al.	514/371
*	D	US-4,277,489	07-1981	Vandoni, Guido	514/414
*	E	US-7,034,049	04-2006	Pevarello et al.	514/404
*	F	US-6,218,418	04-2001	Pevarello et al.	514/404
*	G	US-6,911,466	06-2005	Koo et al.	514/420
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Pevarello et al (2000): STN International HCAPLUS database, (Columbus, Ohio), Accession number: 2000:314687. ✓
	V	Koo et al (2001): STN International HCAPLUS database, (Columbus, Ohio), Accession number: 2001:780679. ✓
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.